INFORMATION DISCLOSURE					Complete if Known							
					Application Number			NA 10/524506				
					Nat. Phase Filing Date			February 14, 2005				
STATEMENT BY APPLICANT						Name	ed Inventor	FREDERIX				
						Art	Unit	NA				
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁰Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

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				İ	Application Number	10/524506	524506					
INFORMATION DISCLOSURE STATEMENT BY APPLICANT					Nat. Phase Filing Date	February 14, 2005						
					First Named Inventor	FREDERIX						
					Group Art Unit	NA						
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